## AMENDMENTS TO THE CLAIMS:

This listing of claims will replace all prior versions and listings of claims in the application:

## LISTING OF CLAIMS:

1. (Currently Amended) A semiconductor device comprising:

clock buffer means for receiving and buffering an external clock signal and then outputting an internal clock in response to a second control signal;

clock enable buffer means, which is enabled by a buffer enable signal, for comparing a reference voltage having a constant potential with a clock enable buffer signal and then enabling the clock buffer means generating a first control signal;

clock enable signal timing control means for outputting the second control signal by passing the clock enable signal to the clock buffer means in response to the buffer enable signal or by delaying the clock enable signal for a predetermined time; and

clock enable signal latch means for enabling the clock enable buffer means using the clock enable buffer signal generating the enable signal after a power-up signal is inputted.

## 2. (Canceled)

3. (Currently Amended) The semiconductor device as recited in Claim  $\frac{1}{2}$ , wherein the clock enable signal latch means includes:

a first clock enable signal latch unit which is enabled according to the power-up signal to transfer the clock enable signal and is disabled according to an enable signal for generating a first output signal according to the power-up signal and the buffer enable signal; and

buffer means and for receiving the first output signal to thereby outputs output the enable signal to disable the first clock enable signal latch unit, the clock enable buffer means and the clock enable signal timing control means using an output signal from the first clock enable signal latch unit.

- 4. (Currently Amended) The semiconductor device as recited in Claim 3, wherein the first clock enable signal latch unit includes:
- a NAND gate receiving the power-up signal and the enable signal;
- a first PMOS transistor which has a gate receiving the clock enable buffer signal and is connected to the power voltage;
- a first NMOS transistor which has a gate receiving the clock enable buffer signal and is connected to the first PMOS transistor;
- a second NMOS transistor which has a gate receiving an output signal from the NAND gate and is connected to both the first NMOS transistor and a ground voltage level;

a second PMOS transistor which has a gate receiving the output signal from the NAND gate and is connected to both the power voltage; and

a first inverter connected between the first NMOS transistor and the second PMOS transistor in order to invert a voltage level on the common node of the first NMOS transistor and the first PMOS transistor for generating the first output signal.

- 5. (Currently Amended) The semiconductor device as recited in Claim 4, wherein the second clock enable signal latch unit includes:
- a third PMOS transistor which has a gate receiving the power-up signal and is connected to the power voltage;
- a fourth PMOS transistor which has a gate receiving the first output signal an output signal from the first inverter and is connected to the third PMOS transistor;
- a third NMOS transistor which has a gate receiving the first output signal the output signal from the first inverter and is connected to both the fourth PMOS transistor and the ground voltage level; and
- a second inverter to invert a voltage level on a common node of the fourth PMOS transistor and the third NMOS transistor for generating the buffer enable signal.
  - 6. (Currently Amended) The semiconductor device as recited in

Claim 3, wherein the clock enable signal timing control means includes:

a clock enable signal path selection unit which for outputting the second control signal to the clock buffer means passes by passing the first control signal to the clock signal latch unit or outputs a delayed signal to the clock signal latch unit by delaying the first control signal; and

a path controller to control the <u>a</u> transfer path of the first control signal on the clock enable signal path selection unit in response to the <u>buffer</u> enable signal.

- 7. (Currently Amended) The semiconductor device as recited in Claim 6, wherein the clock enable signal path selection unit includes:
  - a first delayer to delay the first control signal;
- a first transfer gate to transfer an output of the first delayer to an output terminal as the second control signal; and
- a second transfer gate to directly transfer the first control signal to an output terminal as the second control signal.
- 8. (Currently Amended) The semiconductor device as recited in Claim 7, wherein the path controller includes:
- a first PMOS transistor which has a gate receiving the <u>buffer</u> enable signal;

a second PMOS transistor which has a gate receiving an output signal of the clock enable signal path selection unit the second control signal and is connected to the first PMOS transistor;

a first NMOS transistor which has a gate receiving the output signal of the clock enable signal path selection unit the second control signal and is connected to the second PMOS transistor and the ground voltage level;

a first inverter to invert a voltage level on the common node of the second PMOS transistor and the first NMOS transistor and to produce a first turn-on signal turning on the second transfer gate;

a second inverter to invert an output signal of the first inverter and to produce a second turn-on signal turning on the second transfer gate;

a second delayer which is connected to the second inverter to and produces a third turn-on signal turning on the first transfer gate; and

a third delayer which is connected to the first inverter to and produces a third turn-on signal turning on the first transfer gate.

9. (Currently Amended) The semiconductor device as recited in Claim 7, wherein the clock enable signal path selection unit further includes:

an inverter for inverting the power-up signal; and

an NMOS transistor for receiving an output of the inverter and connecting to connect an input terminal of the inverter the first delayer to a ground voltage level.

10. (Currently Amended) The semiconductor device as recited in Claim 8, wherein the path controller further includes:

a third inverter connected to a common node of the second PMOS transistor and the first NMOS transistor an output terminal of the first inverter; and

a third PMOS transistor having a gate to receive an output of the third inverter and being connected to the common node of the second PMOS transistor and the first NMOS transistor.

11. (Currently Amended) The semiconductor device as recited in Claim 1, wherein the clock enable buffer means includes:

first and second NMOS transistors which have gates receiving the reference voltage and the clock enable buffer signal, respectively;

a third NMOS transistor which has a gate receiving the <u>buffer</u> enable signal and is connected to the first and second NMOS transistors and to a ground voltage level;

a first PMOS transistor which has a gate connected to the first NMOS transistor in a diode connection and is connected to a power voltage;

a second PMOS transistor which is connected to the power voltage and the <u>second NMOS</u> transistor to form a current mirror together with the first PMOS transistor;

a third PMOS transistor which has a gate receiving the <u>buffer</u> enable signal and is connected to the first NMOS transistor and the power voltage;

a fourth PMOS transistor which has a gate receiving the <u>buffer</u> enable signal and is connected to the second NMOS transistor and the power voltage; and

an inverter for inverting an output signal from the common node of the second PMOS transistor and the second NMOS transistor and outputting a control signal to control the clock buffer means.

12. (NEW) The semiconductor device as recited in Claim 1, wherein the clock buffer means includes:

an input buffer for receiving and buffering the external clock signal; and

a clock signal latch unit for transferring an output signal of the input buffer according to the second control signal.